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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/669,149	09/23/2003	Erich Strasser	56/417 2988		
757	7590 11/15/2005		EXAMINER		
BRINKS H	OFER GILSON & LIO	MONBLEAU, DAVIENNE N			
P.O. BOX 10 CHICAGO,	· · · ·		ART UNIT	PAPER NUMBER	
011101100,	22 00010		2878		
			DATE MAIL ED: 11/15/2005		

Please find below and/or attached an Office communication concerning this application or proceeding.

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		Applicat	ion No.	Applicant(s)	-4.)			
Office Action Summary		10/669,	149	STRASSER, ERICH				
		Examine	er	Art Unit				
		Davienne	e Monbleau	2878				
Period fo	The MAILING DATE of this commu or Reply	nication appears on th	e cover sheet with	the correspondence ad	dress			
WHIC - Exte after - If NC - Failu Any	IORTENED STATUTORY PERIOD FOR CHEVER IS LONGER, FROM THE MENTION OF THE MENTION O	MAILING DATE OF T s of 37 CFR 1.136(a). In no e munication. statutory period will apply and v y will, by statute, cause the ap	HIS COMMUNICA vent, however, may a reply will expire SIX (6) MONTH plication to become ABAN	TION. y be timely filed S from the mailing date of this co DONED (35 U.S.C. § 133).				
Status								
1)⊠	Responsive to communication(s) fil	ed on 15 Sentember	2005					
2a)□		2b)⊠ This action is						
3)□		•		s prospertion as to the	morito io			
ت (۵	Since this application is in condition for allowance except for formal matters, prosecution as to the ments is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.							
		ace under Ex parte Q	uayic, 1000 O.D. 1	1, 400 0.0. 210.				
Disposit	ion of Claims							
4)⊠	Claim(s) <u>1-19</u> is/are pending in the application.							
_	4a) Of the above claim(s) is/are withdrawn from consideration.							
5)∐	Claim(s) is/are allowed.							
6)⊠	· · · · · · · · · · · · · · · · · · ·							
7)	Claim(s) is/are objected to.							
8)[Claim(s) are subject to restri	ction and/or election	requirement.					
Applicat	ion Papers							
9)	The specification is objected to by the	ne Examiner.						
10)🖂	The drawing(s) filed on 23 Septemb	<i>er 200</i> 3 is/are: a)⊠	accepted or b) C	biected to by the Exan	niner.			
,—	Applicant may not request that any obje							
	Replacement drawing sheet(s) including				R 1 121(d)			
11)	The oath or declaration is objected t				• •			
	under 35 U.S.C. § 119							
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	Acknowledgment is made of a claim ☐ All b)☐ Some * c)☐ None of: 1.☐ Certified copies of the priority			19(a)-(d) or (f).				
	2. Certified copies of the priority			lication No				
	3. Copies of the certified copies				Stage			
	application from the Internation							
* 5	See the attached detailed Office action	•	` <i>''</i>	ceived.				
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Attachmen	t(s)							
_	e of References Cited (PTO-892)		4) Interview Sum	mary (PTO-413)				
Notice of Draftsperson's Patent Drawing Review (PTO-948) Paper No(s)/Mail Date. 11/8/05.								
	mation Disclosure Statement(s) (PTO-1449 or er No(s)/Mail Date	r PTO/SB/08)		mal Patent Application (PTO	-152)			
Paper No(s)/Mail Date 6) Uther:								

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DETAILED ACTION

Withdrawal of Finality

Applicant's request for reconsideration of the finality of the rejection of the last Office action (dated 10/19/05) is persuasive and, therefore, the finality of that action is withdrawn. (See attached interview summary.) A new action on the merits for claims 1-19 follows.

Response to Amendment

The amendment filed on 9/15/05 has been entered. Claim 1 has been amended. New Clams 18 and 19 have been added. Claims 1-19 are pending.

Claim Objections

Regarding Claim 19, the phrase "wherein said detector arrangement comprises a plurality of detector elements" is not further limiting because Claim 1 already recites "an arrangement of detector elements."

Claim 19, line 2: "each on" should be changed to -- each one -- .

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

(e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

Claims 1, 8, 10-12, 18, and 19 are rejected under 35 U.S.C. 102(e) as being anticipated by Mayer et al. (U.S. 6,472,658).

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The applied reference has a common assignee with the instant application. Based upon the earlier effective U.S. filing date of the reference, it constitutes prior art under 35 U.S.C. 102(e). This rejection under 35 U.S.C. 102(e) might be overcome either by a showing under 37 CFR 1.132 that any invention disclosed but not claimed in the reference was derived from the inventor of this application and is thus not the invention "by another," or by an appropriate showing under 37 CFR 1.131.

Regarding Claim 1, Mayer discloses in Figures 1 and 6 a position measuring instrument comprising a periodic incremental graduation (2) comprising a plurality of graduation periods within one measurement range, a reference marking (R) disposed within said measurement range and integrated with said incremental graduation (2), and an arrangement of detector elements (5, 6) over at least a length of said measurement range for generating a plurality of periodic scanning signals (column 5 lines 5-20) of which at least one is modified locally by said reference marking (R). Mayer discloses (column 7, lines 61-65) determining an absolute position of said reference marking within said length of said measurement range as a function of said detected at least one scanning signal. Thus, it is inherent that there is an evaluation device that receives said scanning signals and detects at least one scanning signal, modified by said reference marking, from said plurality of scanning signals in order to determine that position.

Regarding Claim 12, Mayer discloses in Figures 1 and 6 a method for position measurement comprising scanning (column 5 lines 5-20) a plurality of graduation periods of one incremental graduation (2) by a detector arrangement extending over a length of one measurement range, a reference marking (R) being integrated with one of said graduation periods, and generating a plurality of periodic scanning signals, of which at least one is locally

modified by said reference marking (R), detecting (5, 6) said at least one scanning signal, modified by said reference marking (R), from among said plurality of periodic scanning signals, and determining an absolute position of said reference marking within said length of said measurement range as a function of said scanning signal detected (column 7 lines 61-65).

Regarding Claim 8, *Mayer* discloses in Figure 6, that said reference marking (R) is a variation of an interstice in a series of equally spaced markings which forms said incremental graduation (2).

Regarding Claim 10, *Mayer* discloses in Figure 1 that parallel to and next to said incremental graduation (2), an absolute code (1) for absolute position measurement is disposed at measurement increments in accordance with said length of one measurement range.

Regarding Claim 11, *Mayer* discloses that said absolute code (1) is a single-track sequential code with successive code elements.

Regarding Claims 18 and 19, *Mayer* discloses in Figure 1 detector arrangements comprising a plurality of detector elements (5, 6), wherein each detector element is assigned to its own corresponding location within said length of said measurement range and said absolute position of said reference marking determined by said evaluation device is one of said corresponding locations of said detector elements within said length of said measurement range.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

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(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 2-7, 9, and 13-17 are rejected under 35 U.S.C. 103(a) as being obvious over Mayer in view of Omi (U.S. 5,841,133).

The applied reference has a common assignee with the instant application. Based upon the earlier effective U.S. filing date of the reference, it constitutes prior art only under 35 U.S.C. 102(e). This rejection under 35 U.S.C. 103(a) might be overcome by: (1) a showing under 37 CFR 1.132 that any invention disclosed but not claimed in the reference was derived from the inventor of this application and is thus not an invention "by another"; (2) a showing of a date of invention for the claimed subject matter of the application which corresponds to subject matter disclosed but not claimed in the reference, prior to the effective U.S. filing date of the reference under 37 CFR 1.131; or (3) an oath or declaration under 37 CFR 1.130 stating that the application and reference are currently owned by the same party and that the inventor named in the application is the prior inventor under 35 U.S.C. 104, together with a terminal disclaimer in accordance with 37 CFR 1.321(c). This rejection might also be overcome by showing that the reference is disqualified under 35 U.S.C. 103(c) as prior art in a rejection under 35 U.S.C. 103(a). See MPEP § 706.02(1)(1) and § 706.02(1)(2).

Regarding Claim 2, *Mayer* teaches (Figures 1 and 6; column 4, lines 1-10) that within said measurement range, N graduation periods are disposed, where N>1 and is an integer. *Mayer* teaches using plurality of detectors, but does not teach that said arrangement of detector elements over said length of said measurement range forms N groups, and each of said N groups of detector elements extends over said length of one graduation period, and within each of said N

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groups, a plurality of detector elements are spaced apart from one another by a fraction of one graduation period, so that, within one of said N groups, a plurality of periodic scanning signals phase-offset from one another are generated. Omi teaches in Figure 3 a linear position encoder comprising an incremental graduation (1) with a measurement range and at least two groups of detectors (each with 4 detectors) wherein each detector group extends over one graduation period and the detector elements (PDA, PDAB, PDAB, PDBB) within each detector group are spaced apart from one another by a fraction of one graduation period, so that, a plurality of periodic scanning signals phase-offset from one another are generated. It would have been obvious to one of ordinary skill in the art at the time of the invention to use a plurality of detector groups in Mayer, as taught by Omi, to improve the resolution and position detection accuracy.

Regarding Claims 3-5 and 13-17, methods for determining the absolute position of an object by evaluating the detected phase signals from the encoder are well known and involve standard data analysis techniques. This includes comparing the detected phase signals from the scanned beams and interpolating the absolute position from the detected signals.

Regarding Claim 6, Mayer teaches in Figure 6 that said reference marker (R) is integrated into the incremental graduation (2), which is a phase grating. Thus, there is going to be interference in periodicity at the reference marker (R) location within the incremental graduation. Using a particular size reference marker (R) within said incremental graduation (2) depends on the desired characteristics of the position encoder. Furthermore, methods for determining the absolute position of an object by evaluating detected phase signals from the encoder are well known and involve standard data analysis techniques and may include comparing the detected phase signals from the scanned beams.

Regarding Claim 7, methods for determining the absolute position of an object by evaluating the detected phase signals from the encoder are well known and involve standard data analysis techniques. This includes comparing the detected phase signals from the scanned beams and interpolating the absolute position from the detected signals.

Regarding Claim 9, *Mayer* teaches in Figure that said reference marker (R) has a few components but does not teach a second reference marker. It would have been obvious, however, to one of ordinary skill in the art at the time of the invention to use a second reference marker in *Mayer* to more accurately determine the absolute position of the device.

Response to Arguments

Applicant's arguments filed 9/15/05 have been fully considered but they are not persuasive. Applicant makes the following arguments:

- A. Mayer does not teach an evaluation device that receives signals from an arrangement of detector elements.
- B. Mayer does not detect a signal modified by a reference marker from a plurality of scanning signals.
- C. The absolute position in *Mayer* is not determined as a function of a detected scanning signal modified by a reference marking.

Regarding argument A, Examiner agrees that elements 5 and 6 are photodetectors but does not find Applicant's argument persuasive because *Mayer* inherently includes an evaluation device that receives the signals in order to determine the position. This evaluation device may either be integral with or external to the detectors (5, 6).

Regarding argument B, Applicant's argument is not persuasive because the reference marker (R) modulates the scanned beams (column 5 lines 5-39.) Thus, the position is determined by a signal modified by a reference marker (R). (See also column 7, lines 56-65.)

Regarding argument C, since argument B is not persuasive, it follows that *Mayer* does discloses determining a position as a function of a detected scanning signal modified by a reference marking.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Davienne Monbleau whose telephone number is 571-272-1945. The examiner can normally be reached on Monday through Friday 9-5.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Georgia Epps can be reached on 571-272-2328. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

DNM

Invienne Monbleau

Stephone B. Allen
Primary Examiner